

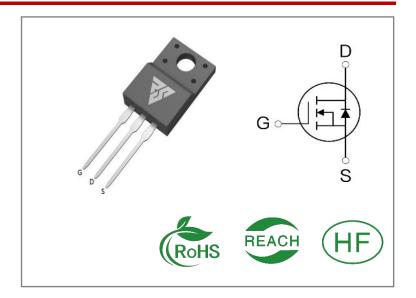
ID	R _{DS} (ON)(Typ)	VDSS
3A	5.5Ω	1500V

Applications:

- Switch Mode Power Supply(SMPS)
- Uninterruptible Power Supply (UPS)
- Power Factor Correction (PFC)

Features:

- Fast switching speed
- 100% avalanche tested
- Improved dv/dt capability



Ordering Information

Part Number	Package	Marking	Packing	Qty.
RS3N150F	T0-220F	RS3N150F	Tube	50 PCS

Absolute Maximun Ratings Tc= 25℃ unless otherwise specified

Symbol	Parameter	RS3N150F	Units
VDSS	Drain-to-Source Voltage	1500	V
ID	Continuous Drain Current TC=25℃	3	۸
IDM	Pulsed Drain Current (Note*1)	12	А
PD	Power Dissipation	48	W
VGS	Gate- to- Source Voltage	±30	V
EAS	Single Pulse Avalanche Engergy L = 10mH, VDD = 50V, RG = 25 Ω	88	mJ
	Maximum Temperature for Soldering		
TL TPKG	Leads at 0.063in(1.6mm)from Case for 10 seconds Package Body for 10 seconds	300 260	$^{\circ}\!$
TJ and TSTG	Operating Junction and Storage Temperature Range	-55 to 150	

^{*} Drain Current Limited by Maximum Junction Temperature

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" Table may cause permanent damage to the device.



Thermal Resistance

Symbol	Parameter	RS3N150F	Units	Test Conditions
RθJC	Junction-to-Case	2.6	°C/W	Drain lead soldered to water cooled heatsink, PD adjusted for a peak junction temperature of + 1 5 0 $^{\circ}\mathrm{C}$
RθJA	Junction-to- Ambient	62.5		1 cubic foot chamber,free air.

OFF Characteristics TJ= 25℃ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
BVDSS	Drain- to- source Breakdown Voltage	1500			V	VGS=0V,ID=250μ A
IDSS	Drain- to- Source Leakage Current			1	μΑ	VDS=1500V,VGS =0V
IGSS	Gate- to- Source Forward Leakage		1	100	 Λ	VGS=30V ,VDS=0 V
1033	Gate- to- Source Reverse Leakage			-100	nA	VGS=-30V ,VDS= 0V

ON Characteristics TJ=25°C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
RDS(on)	Static Drain- to- Source On- Resistance(Note*2)		5.5	6.5	Ω	VGS=10V,ID=1.5 A
VGS(TH	Gate Threshold Voltage	3		5	٧	VGS=VDS,ID=25 0μA

Resistive Switching Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
td(ON)	Turn- on Delay Time		48			
trise	Rise Time		6			VDS=750V
td(OFF)	Turn- OFF Delay Time		25		nS	ID=3A RG=25Ω
tfall	Fall Time		6			



Dynamic Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
Ciss	Input Capacitance		1275			VGS=0V
Coss	Output Capacitance		98		pF	VDS=25V
Crss	Reverse Transfer Capacitance		12			f=1.0MHz
Qg	Total Gate Charge		50			VDS=1200V
Qgs	Gate- to- Source Charge		6		nC	ID=3A
Qgd	Gate-to-Drain(" Miller") Charge		25			VGS=10V

Source-Drain Diode Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
IS	Continuous Source Current			3	Α	Integral pn- diode
ISM	Maximum Pulsed Current			12	Α	in MOSFET
VSD	Diode Forward Voltage			1.4	V	IS=1.5A,VGS=0V
trr	Reverse Recovery Time		1060		nS	VGS=0V
Qrr	Reverse Recovery Charge		5.4		μC	IS=3A,di/dt=100A /μs

Notes:

- * 1. Repetitive rating, pulse width limited by maximum junction temperature.
- * 2. Pulse Test: Pulse width ≤ 300μs, Duty Cycle ≤ 1%



Typical Feature Curve

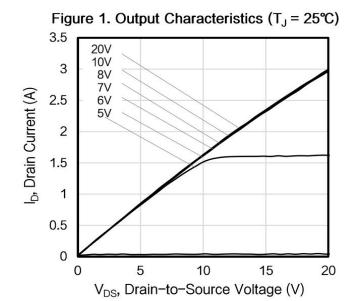
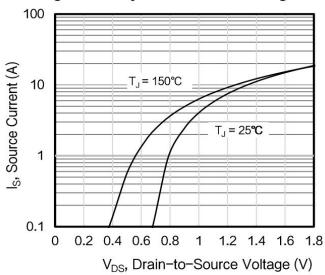


Figure 2. Body Diode Forward Voltage



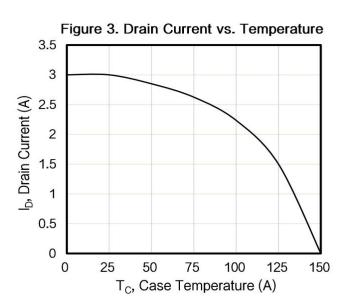


Figure 4.BV_{DSS} Variation vs. Temperature

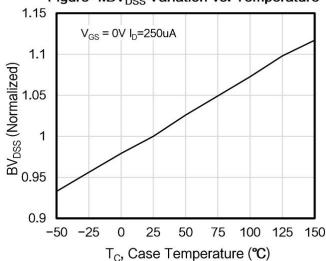


Figure 5. Transfer Characteristics

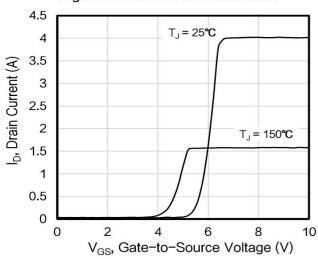
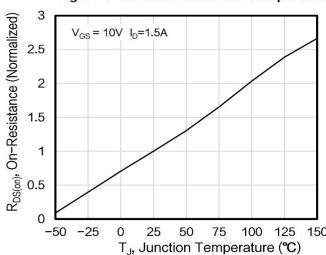


Figure 6. On-Resistance vs. Temperature



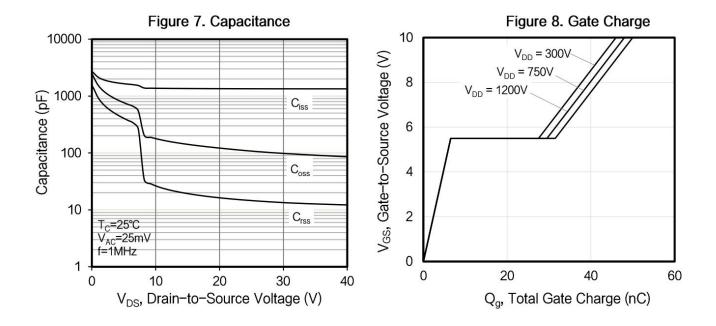
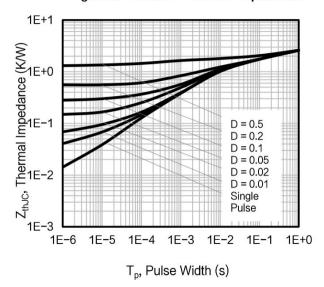


Figure 9. Transient Thermal Impedance



Test Circuits and Waveforms

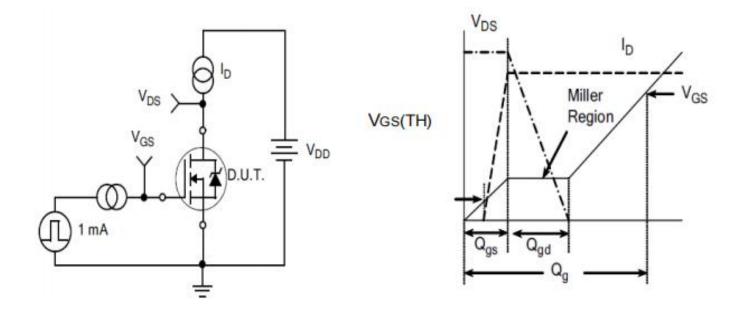


Figure10.
Gate Charge Test Circuit

Figure11.
Gate Charge Waveform

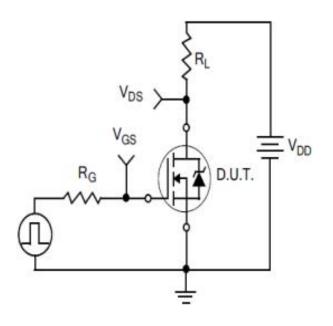


Figure12.
Resistive Switching Test Circuit

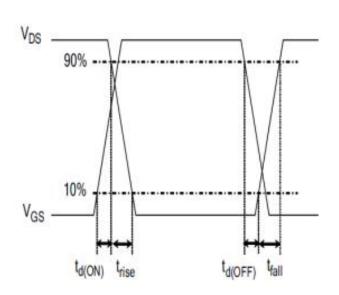


Figure 13.
Resistive Switching Waveforms

Test Circuits and Waveforms

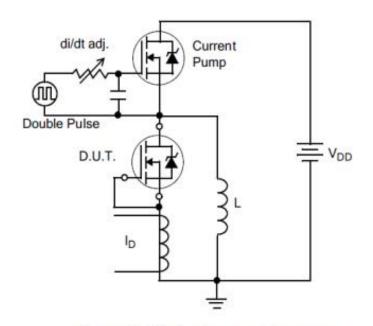


Figure 14. Diode Reverse Recovery
Test Circuit

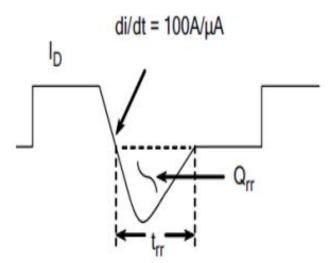


Figure 15. Diode Reverse Recovery Waveform

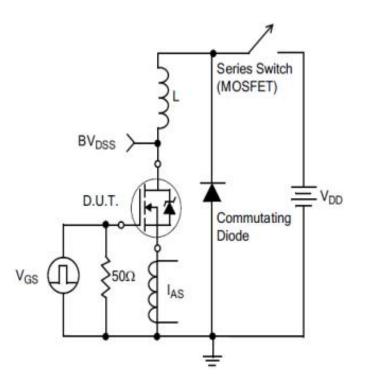
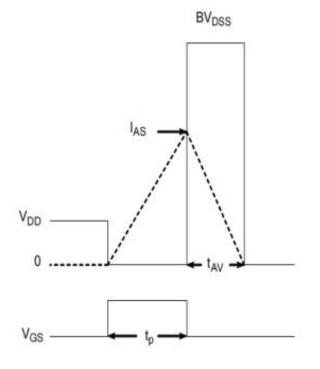
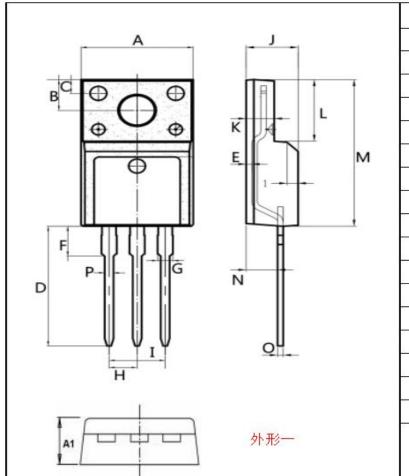


Figure 16. Unclamped Inductive Switching Test Circuit



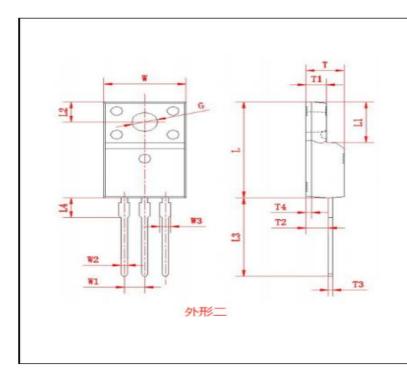


Package outline drawing(TO-220F Unit: mm)



Dim.	Min.	Max.
Α	9.95	10.36
A1	4.5	5.0
В	2.95	3.25
С	1.25	1.45
D	12.60	13.60
E	0.40	0.60
F	2.8	3.5
G	1.30	1.45
Н	(2.54	1)
1	(5.08)	
J	4.60	4.75
K	2.45	2.65
L	6.5	6.8
М	15.4	16.0
N	2.25	3.05
0	0.45	0.55
Р	0.70	0.90

All Dimensions in millimeter



Dim.	Min.	Max.		
W	9.95	10.36		
W1	(2.54)			
W2	0.70	0.90		
W3	1.25	1.47		
L	15.67	16.07		
L1	6.48	6.88		
L2	3.2	3.4		
L3	12.6	13.6		
L4	(3.23)			
Т	4.50	4.90		
T1	2.34	2.74		
T2	2.25	2.95		
ТЗ	0.45	0.60		
T4	(0.	70)		
G	3.08	3.28		



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